

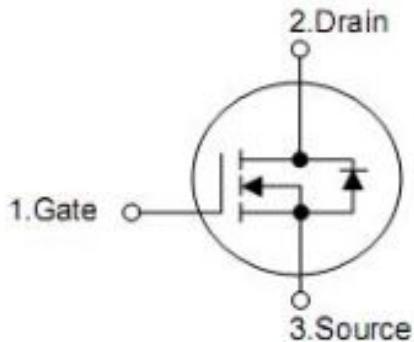
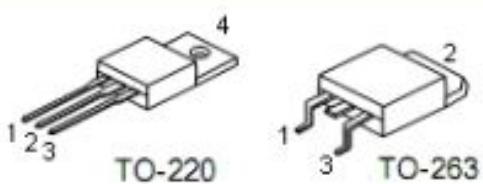
1. Features

- $R_{DS(on)} = 9\text{m}\Omega$ (typ.) @ $V_{GS} = 10\text{V}$
 - 100% avalanche tested
 - Reliable and rugged
 - Lead free and green device available RoHS Compliant

2. Applications

- Switching application
 - Power management for inverter systems

3. Symbol



Pin	Function
1	Gate
2	Drain
3	Source
4	Drain

4. Absolute maximum ratings

(TA=25°C, unless otherwise noted)

Parameter	Symbol	Rating	Units
Drain-source voltage	V _{DSS}	100	V
Gate-source voltage	V _{GSS}	±25	V
Maximum junction temperature	T _J	175	°C
Storage temperature range	T _{STG}	-55 to 175	°C
Continuous drain current	I _D ³	75	A
		51	A
Pulsed drain current	I _{DP} ⁴	219	A
Avalanche current	I _{AS} ⁵	30	A
Avalanche energy	E _{AS} ⁵	225	mJ
Maximum power dissipation	P _D	166	W
		83	W

5. Thermal characteristics

Parameter	Symbol	Rating	Unit
Thermal resistance, Junction-ambient	R _{JA}	62.5	°C/W
Thermal resistance, Junction-case	R _{JC}	0.9	°C/W

6. Electrical characteristics(T_A=25°C, unless otherwise noted)

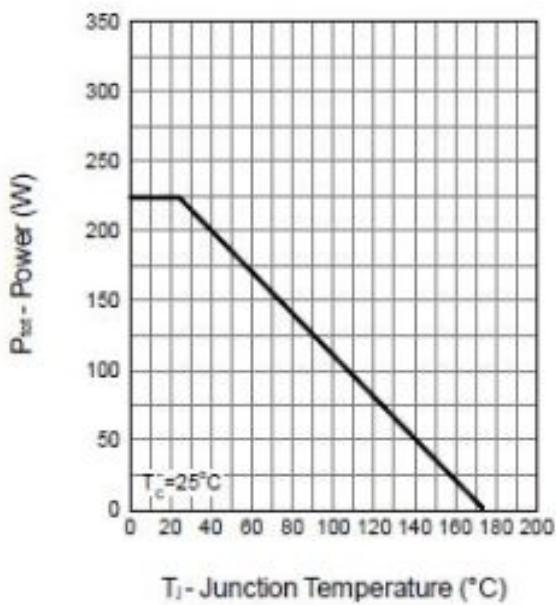
Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Drain-source breakdown voltage	BV _{DSS}	V _{GS} =0V, I _{DS} =250mA	100	-	-	V
Zero gate voltage drain current	I _{DSS}	V _{DS} =80V, V _{GS} =0V	-	-	1	μA
		T _J =125°C	-	-	20	
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} , b=250μA	2.0	3.0	4.0	V
Gate leakage current	I _{GSS}	V _{GS} =±25V, V _{DS} =0V	-	-	±100	nA
Drain-source on-state resistance	R _{DS(on)} ¹	V _{GS} =10V, I _{DS} =50A	-	9	11	mΩ
Gate resistance	R _g	V _{DS} =0V, V _{GS} =0V, f=1MHz	-	1.2	-	Ω
Diode forward voltage	V _{SD} ¹	I _{SD} =50A, V _{GS} =0V	-	-	1.3	V
Reverse recovery time	t _{rr}	I _{SD} =50A, dI _{SD} /dt=100A/μs	-	46	-	nS
Reverse recovery charge	Q _{rr}		-	86	-	nC
Input capacitance	C _{iss}	V _{DS} =25V, V _{GS} =0V, f=1MHz	-	2946	-	pF
Output capacitance	C _{oss}		-	339	-	
Reverse transfer capacitance	C _{rss}		-	179	-	
Turn-on delay time	t _{d(on)}	V _{DD} =50V, I _{DS} =30A, R _G =6.8Ω, V _{GS} =10V	-	15	-	ns
Rise time	t _r		-	108	-	
Turn-off delay time	t _{d(off)}		-	51	-	
Fall time	t _f		-	59	-	
Total gate charge	Q _g	V _{DS} =50V, V _{GS} =10V I _{DS} =30A	-	60	-	nC
Gate-source charge	Q _{gs}		-	13.7	--	
Gate-drain charge	Q _{gd}		-	22.8	--	

- Note : 1. Pulse test; pulse width<300us duty cycle<2%.
2. Guaranteed by design, not subject to production testing.
 3. Package limitation current is 55A.
 4. Repetitive rating, pulse width limited by max junction temperature.
 5. Starting T=25°C, L=0.5mH, A_S=30A.

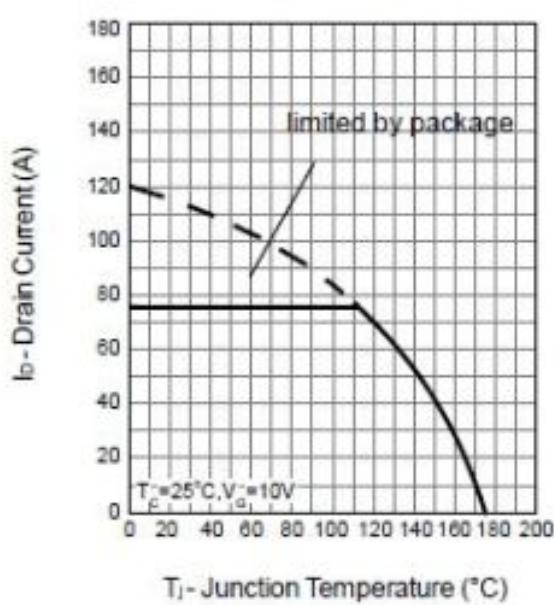
7. Test circuits and waveforms

Typical Operating Characteristics

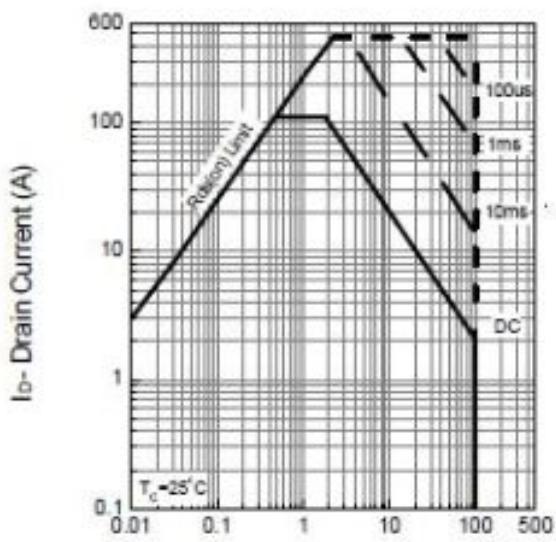
Power Dissipation



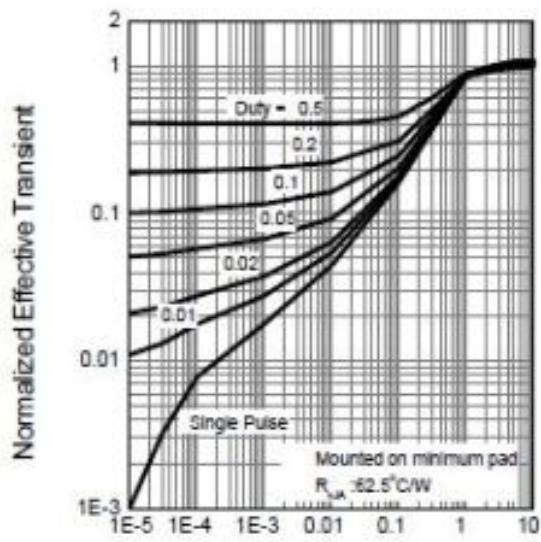
Drain Current



Safe Operation Area



Thermal Transient Impedance

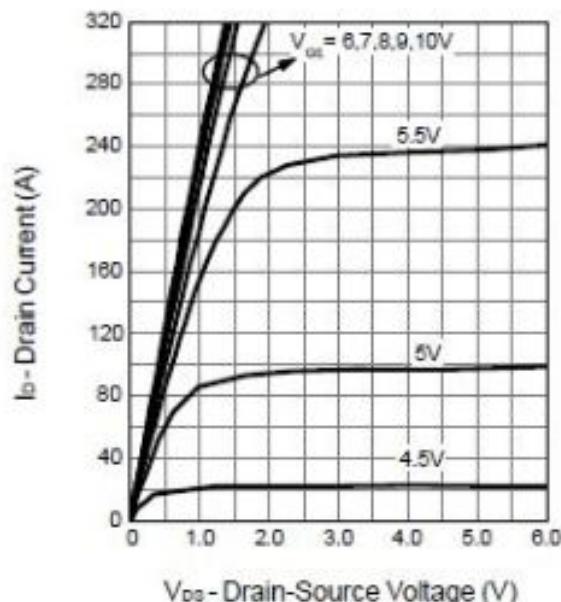
 V_{DS} - Drain - Source Voltage (V)

Square Wave Pulse Duration (sec)

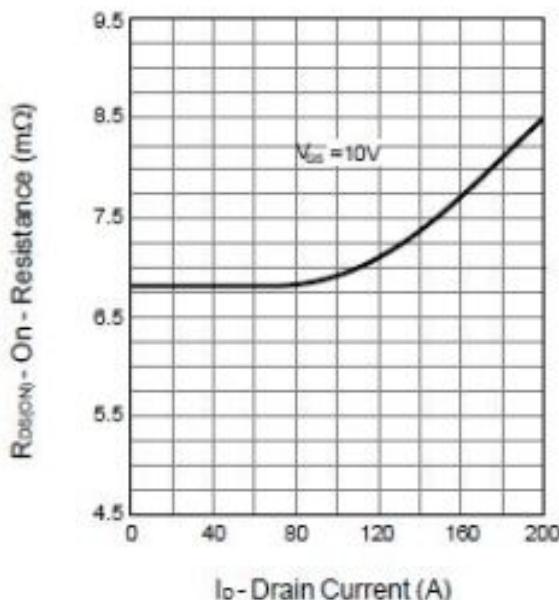
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共享的文档，具体共享方式由上传人自由设
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[了解文档类型](#)

Characteristics (Cont.)

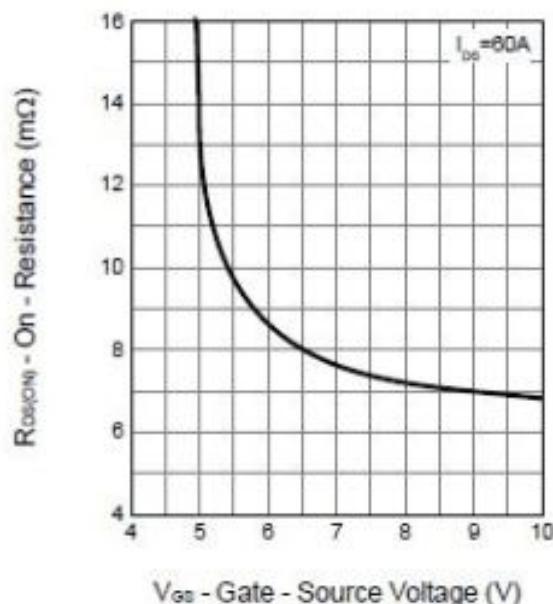
Output Characteristics



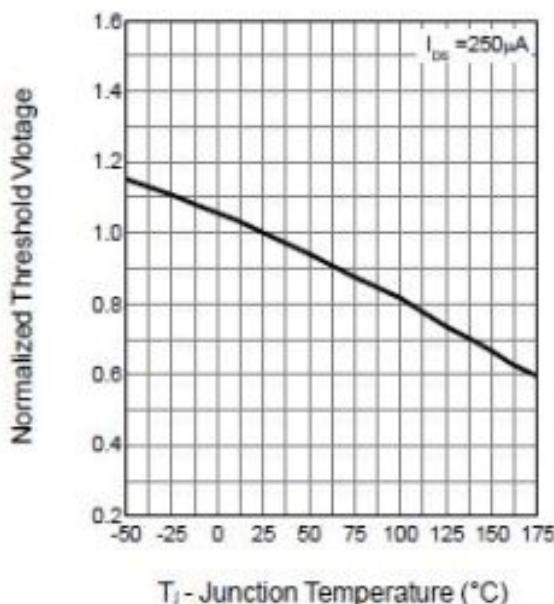
Drain-Source On Resistance



Drain-Source On Resistance

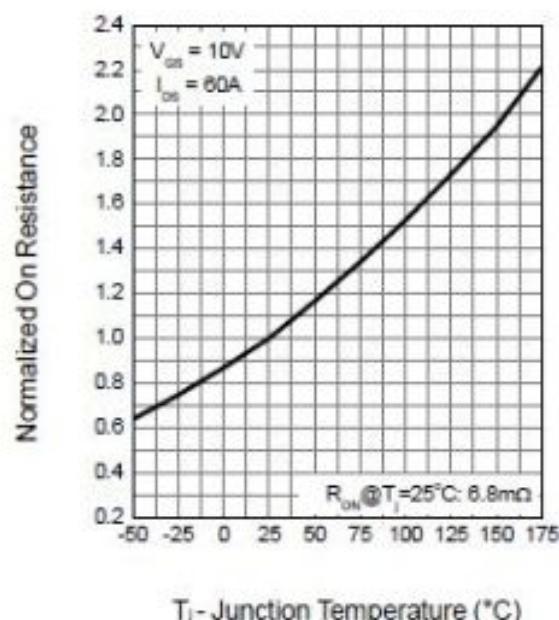


Gate Threshold Voltage

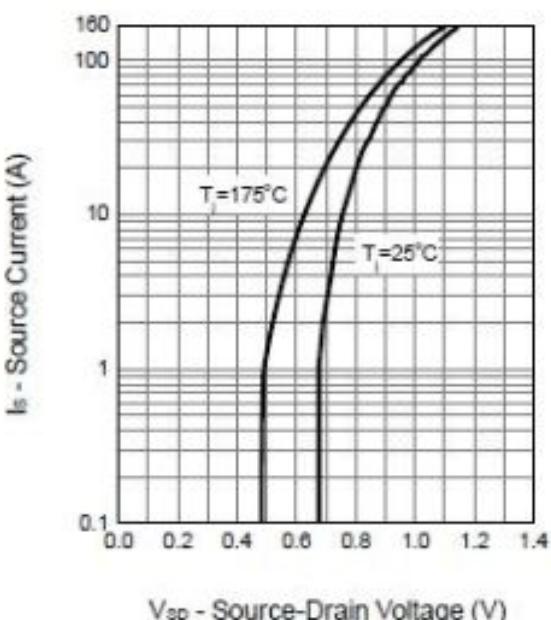


Typical Operating Characteristics (Cont.)

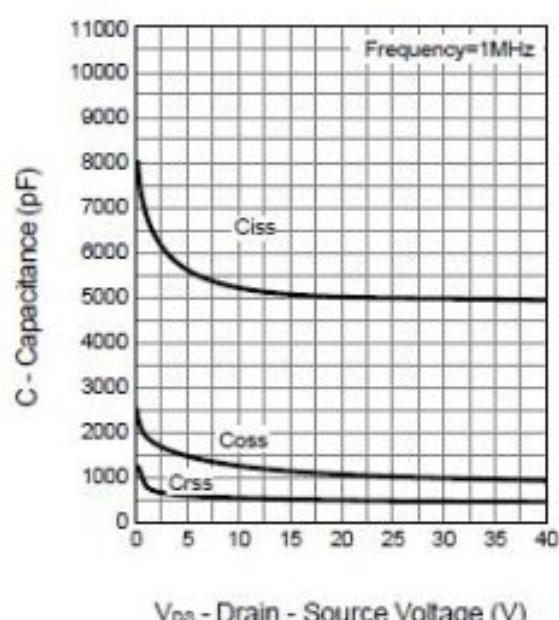
Drain-Source On Resistance



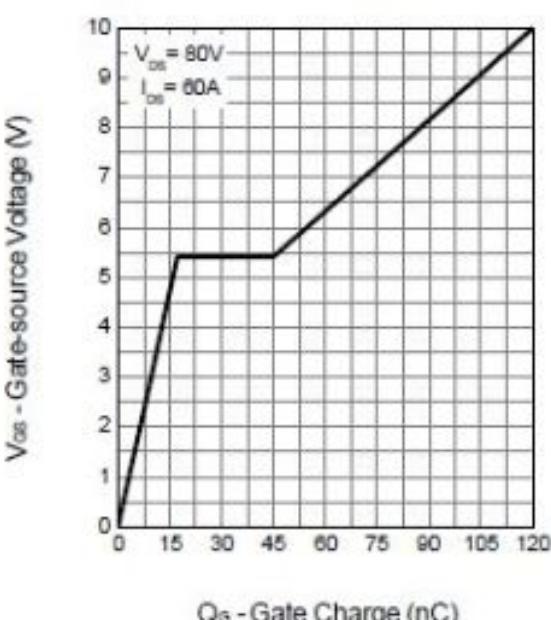
Source-Drain Diode Forward



Capacitance

V_{DS} - Drain - Source Voltage (V)

Gate Charge

Q_g - Gate Charge (nC)